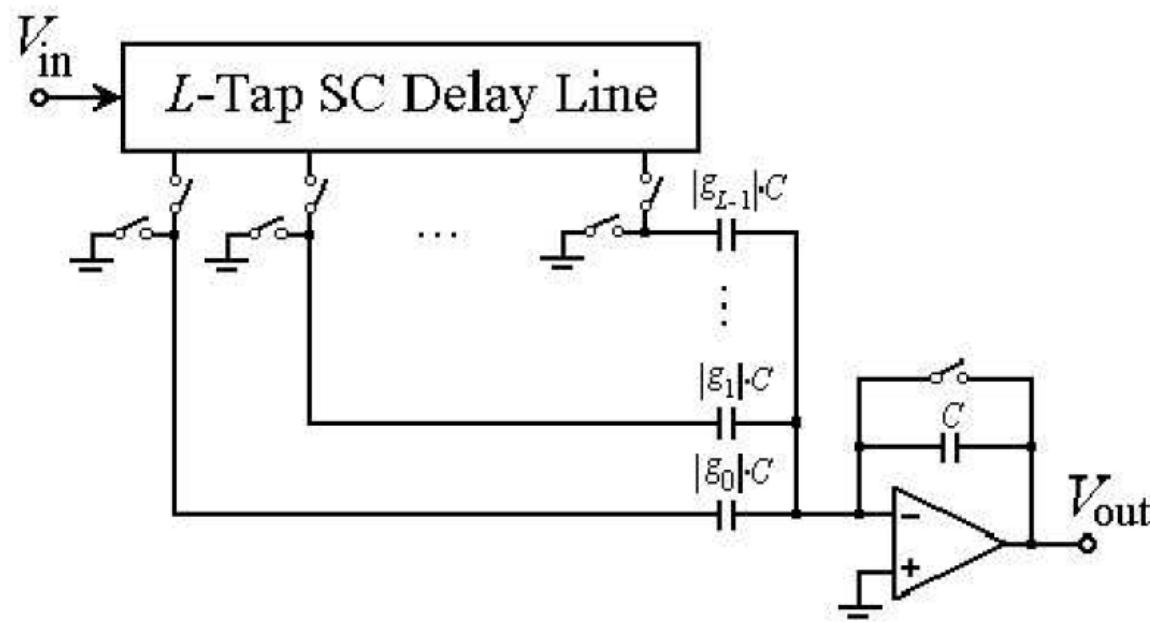


Direct-Form SC Filters

Direct-Form FIR SC Filter Realization

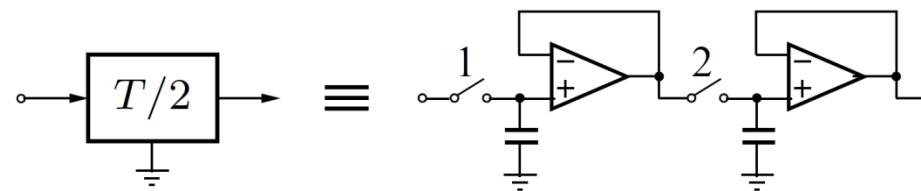
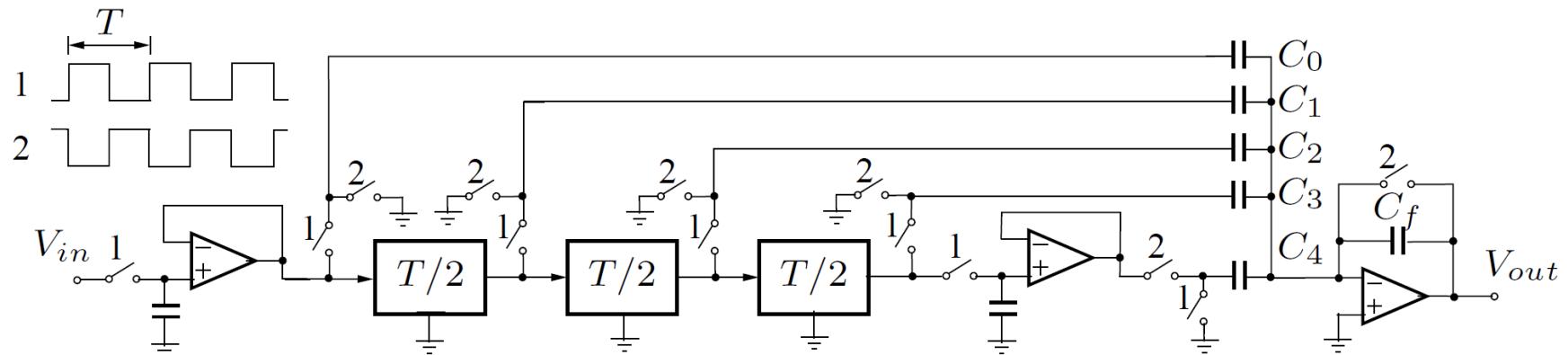
(L-1)th-order FIR SC filter:



$$\frac{V_{out}}{V_{in}}(z) = \sum_{k=0}^{L-1} g_k z^{-k}$$

Direct-Form FIR SC Filter Realization

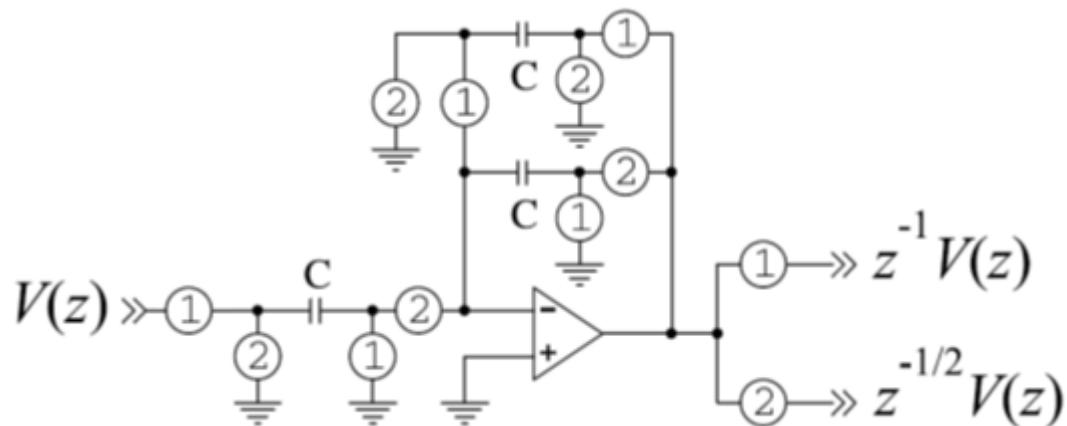
Ex.: 4th-order SC FIR filter



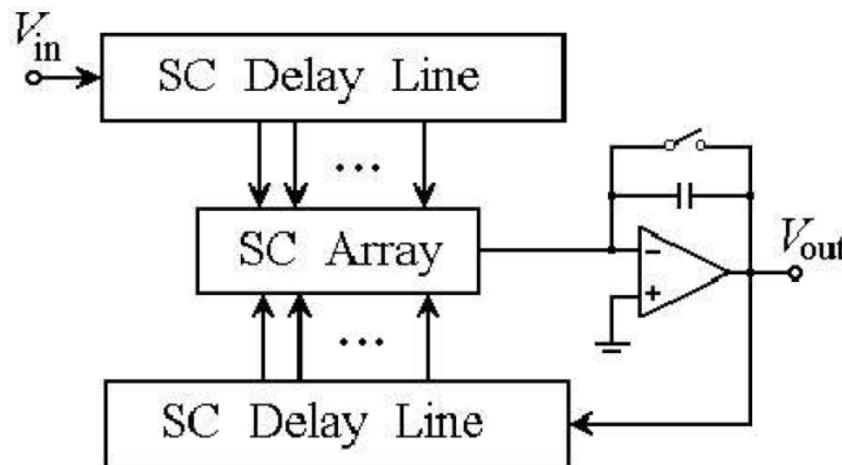
$$\frac{V_{out}}{V_{in}}(z) = -\frac{C_0}{C_f} - \frac{C_1}{C_f}z^{-1} - \frac{C_2}{C_f}z^{-2} - \frac{C_3}{C_f}z^{-3} + \frac{C_4}{C_f}z^{-4}$$

Direct-Form FIR SC Filter Realization

Reduction of the number of amplifiers by a multiplexing technique



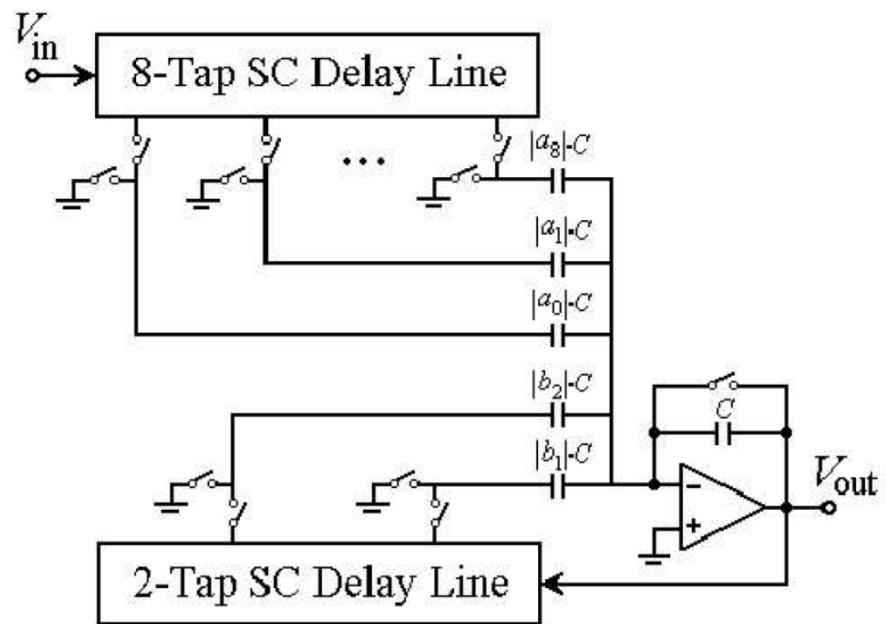
Direct-Form IIR SC Filter Realization



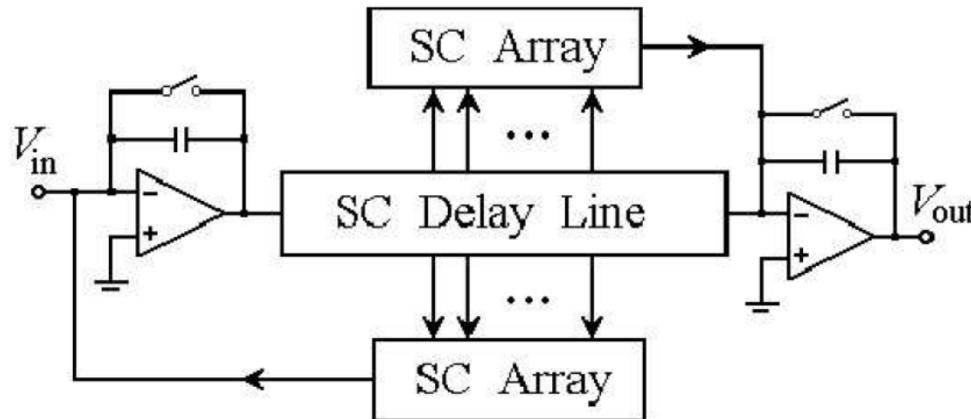
Direct Form I

2 SC delay lines
sharing the same
SC array

$$\text{Ex.: } \frac{V_{out}}{V_{in}}(z) = \frac{a_0 + a_1 z^{-1} + \dots + a_8 z^{-8}}{1 - b_1 z^{-1} - b_2 z^{-2}}$$



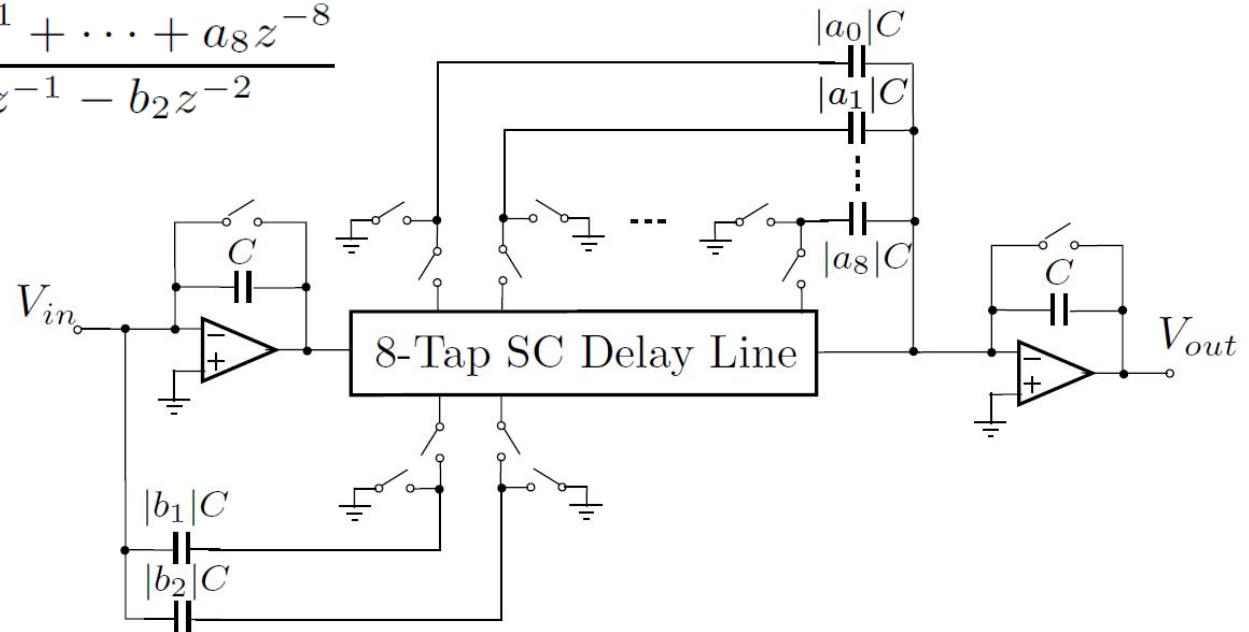
Direct-Form IIR SC Filter Realization



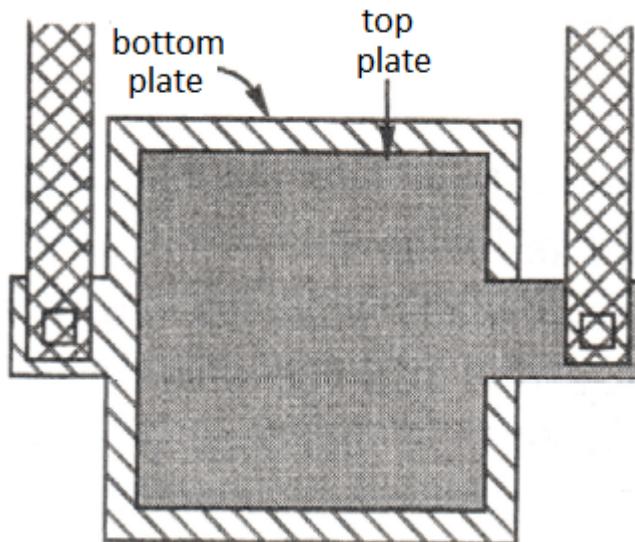
Direct Form II

2 SC arrays sharing
the same SC delay
line

$$\text{Ex.: } \frac{V_{out}}{V_{in}}(z) = \frac{a_0 + a_1 z^{-1} + \cdots + a_8 z^{-8}}{1 - b_1 z^{-1} - b_2 z^{-2}}$$



CMOS Capacitors



$$C = AC_{\text{ox}}$$

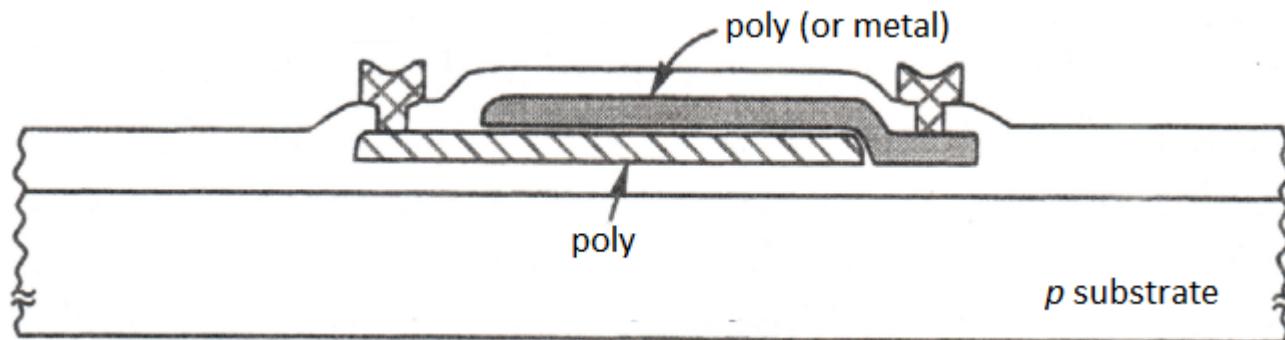
$$C_{\text{ox}} = \epsilon_{\text{ox}} / t_{\text{ox}}$$

For 0.35 μm CMOS:

$$\epsilon_{\text{ox}} \approx 3.5 \times 10^{-13} \text{ F/cm}$$

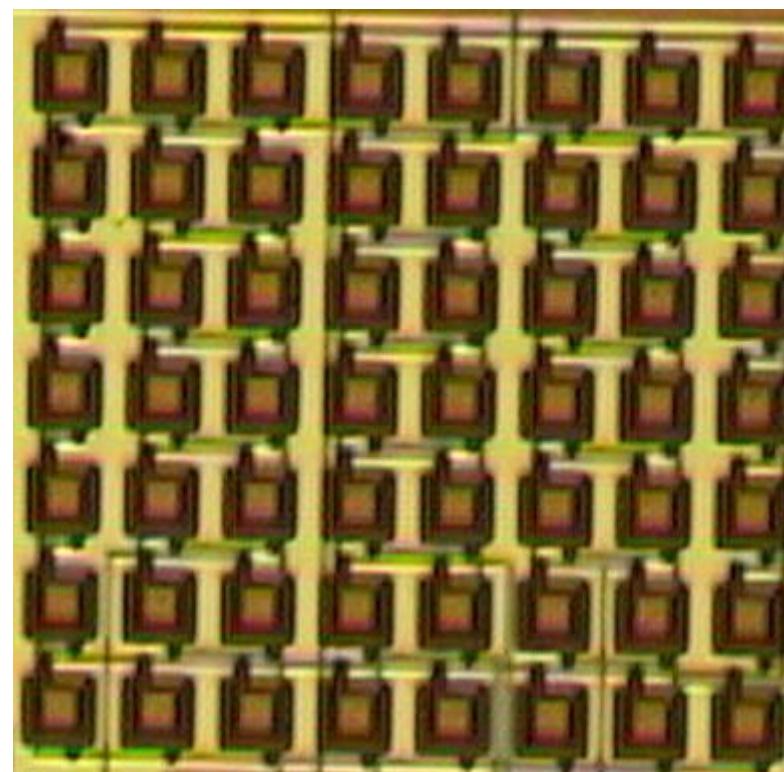
$$t_{\text{ox}} \approx 10 \text{ nm}$$

$$\Rightarrow C_{\text{ox}} \approx 3.5 \text{ fF}/\mu\text{m}^2$$



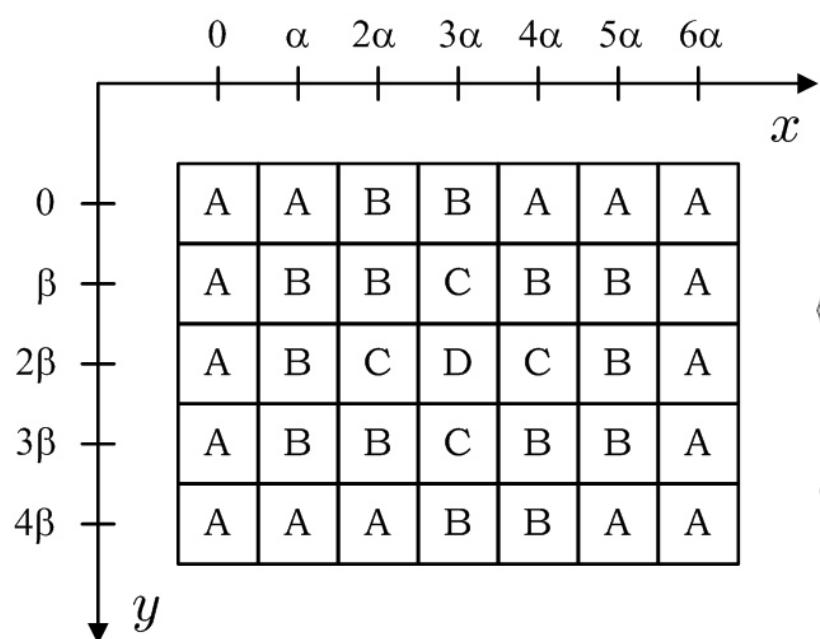
Capacitance Mismatch Effects

Capacitances implemented by parallel associations of identical 0.1 pF units



Capacitance Mismatch Effects

Mismatch caused by process gradients:



Average capacitances assuming
linear process gradient:

$$\langle C_{xy} \rangle_A = \frac{1}{16} \cdot [16C + 48\alpha + 32\beta] = C + 3\alpha + 2\beta$$

$$\langle C_{xy} \rangle_B = \frac{1}{14} \cdot [14C + 42\alpha + 28\beta] = C + 3\alpha + 2\beta$$

$$\langle C_{xy} \rangle_C = \frac{1}{4} \cdot [4C + 12\alpha + 8\beta] = C + 3\alpha + 2\beta$$

$$\langle C_{xy} \rangle_D = C + 3\alpha + 2\beta$$

Capacitance Mismatch Effects

Mathematical model commonly used in computer aided analysis of SC filters:

$$\hat{\gamma}_k = \gamma_k + \epsilon_{\gamma k}$$

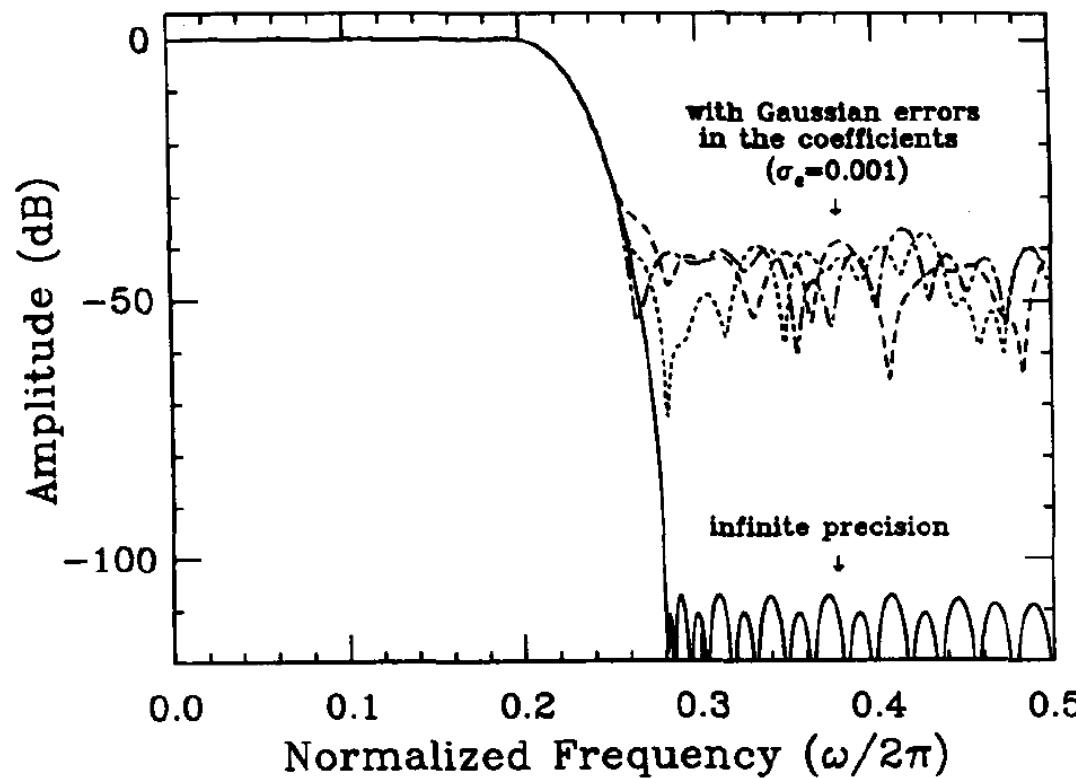
were $\epsilon_{\gamma k} = \gamma_k \epsilon_k$

γ_k : capacitance ratios

ϵ_k : uncorrelated zero-mean Gaussian random variables

Capacitance Mismatch Effects

Ex.: Frequency responses of 3 FIR filters having 50 coefficients and $\sigma_\epsilon = 0.001$



Capacitance Mismatch Effects

a) FIR SC Filters

$$G(e^{j\omega}) = \sum_{k=0}^{L-1} g_k e^{-j\omega k}$$

Each coefficient is implemented as a ratio between two capacitances

Because of random capacitance errors, the actual frequency response is:

$$\begin{aligned}\hat{G}(e^{j\omega}) &= \sum_{k=0}^{L-1} (g_k + \epsilon_{g_k}) e^{-j\omega k} \\ &= G(\omega) + \sum_{k=0}^{L-1} \epsilon_{g_k} e^{-j\omega k}\end{aligned}$$

Capacitance Mismatch Effects

Deviation in the frequency response:

$$\begin{aligned}\Delta G(e^{j\omega}) &= \hat{G}(e^{j\omega}) - G(e^{j\omega}) \\ &= \sum_{k=0}^{L-1} \epsilon_{g_k} e^{-j\omega k}.\end{aligned}$$

where $\epsilon_{g_k} = \bar{g}\epsilon_k$, $\bar{g} = \sum_{k=0}^{L-1} |g_k|/L$

- (i) ϵ_k are random Gaussian mismatches with zero mean and standard deviation σ_ϵ
- (ii) $|\Delta G(e^{j\omega})|$ is a Raileygh random variable with a mean (average) value

$$\overline{|\Delta G|(e^{j\omega})} = \frac{\sigma_g \sqrt{\pi L}}{2}, \quad \forall \omega$$

where $\sigma_g = \bar{g}\sigma_\epsilon$

Capacitance Mismatch Effects

b) IIR SC Filters

$$H(z) = \frac{A(z)}{B(z)} = \frac{\sum_{k=0}^{M-1} a_k z^{-k}}{1 - \sum_{k=1}^{N-1} b_k z^{-k}}$$

Each coefficient is implemented as a ratio between two capacitances

The average deviation in frequency response is:

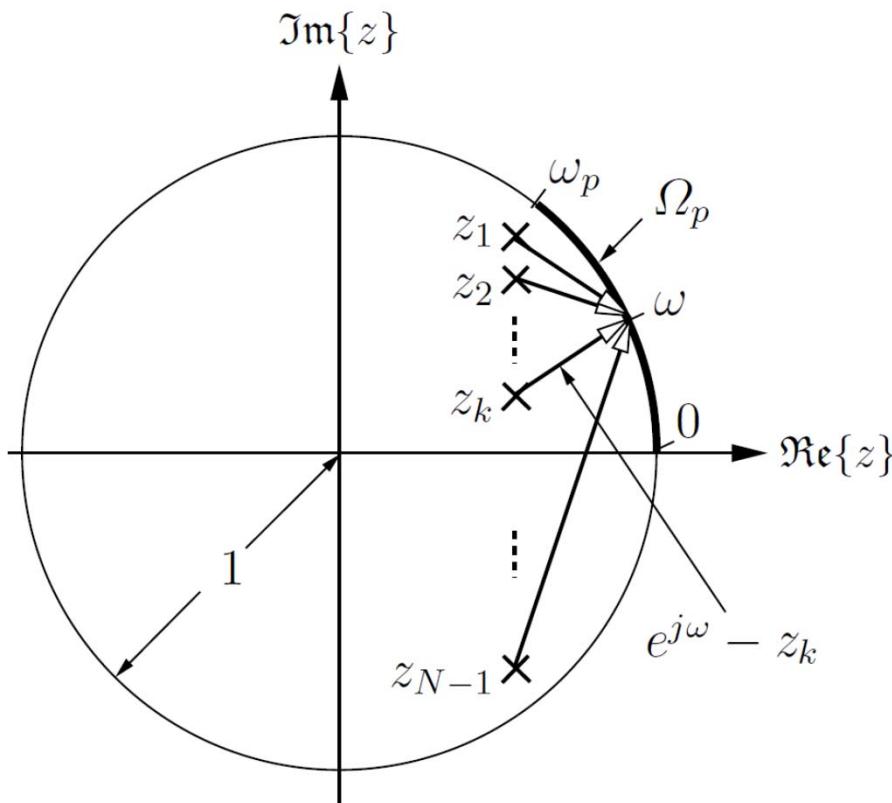
$$\overline{|\Delta H|(e^{j\omega})} = \begin{cases} \frac{\sigma_b \sqrt{\pi(N-1)}}{2|B(e^{j\omega})|}, & \omega \in \Omega_p \\ \frac{\sigma_a \sqrt{\pi M}}{2|B(e^{j\omega})|}, & \omega \in \Omega_s \end{cases}$$

where $\sigma_a = \sigma_\epsilon \sum_{k=0}^{M-1} |b_k|/M$, $\sigma_b = \sigma_\epsilon \sum_{k=1}^{N-1} |b_k|/(N-1)$

Capacitance Mismatch Effects

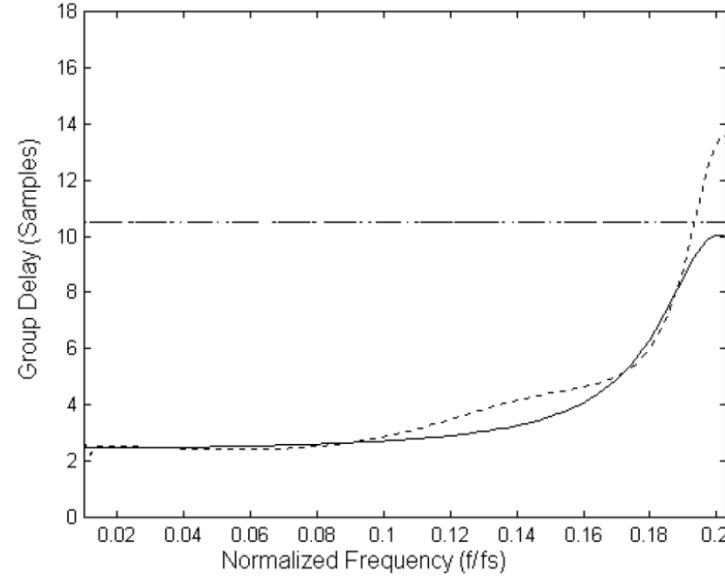
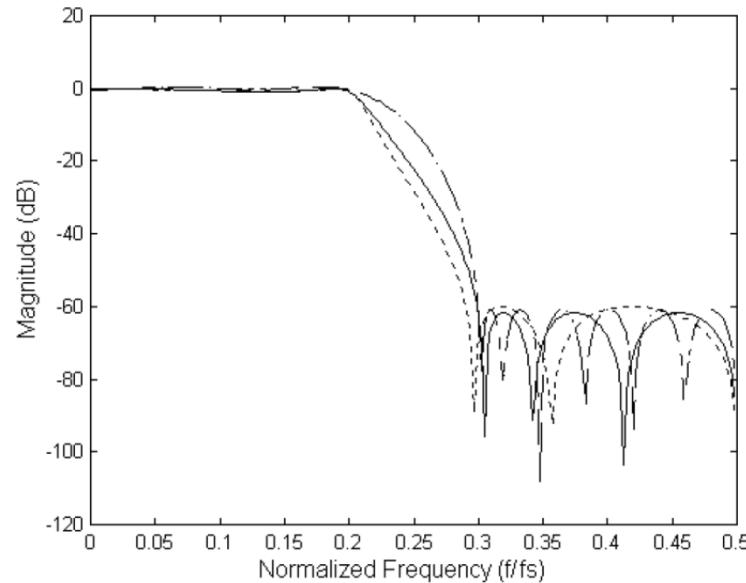
Letting z_1, z_2, \dots, z_{N-1} be the poles of $H(z)$:

$$|B(e^{j\omega})| = |e^{j\omega} - z_1||e^{j\omega} - z_2|\dots|e^{j\omega} - z_{N-1}|$$



Capacitance Mismatch Effects

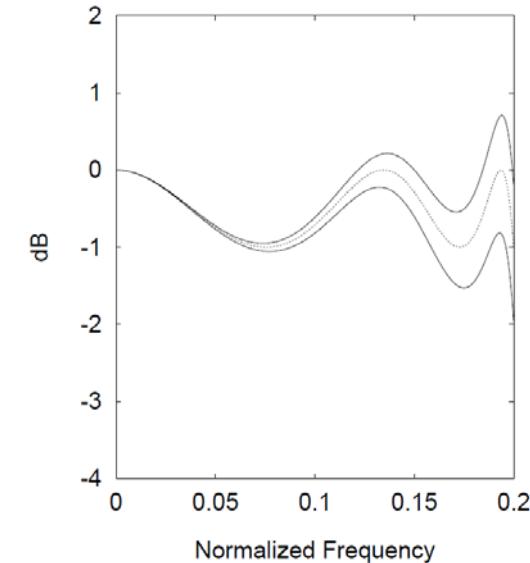
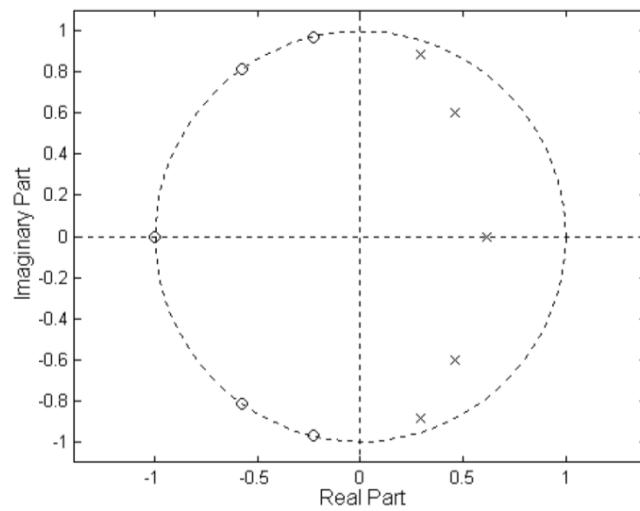
Example: $\omega_p = 0.2$; $\omega_s = 0.3$; $R_p < 1\text{dB}$; $R_s > 60 \text{ dB}$



- Elliptic: $M=N=6$
- Two-pole design: $M=9, N=3$
- FIR: $M=22, N=1$

Capacitance Mismatch Effects

Eliptic:
 $M=N=6$



Two-pole design:
 $M=9, N=3$

